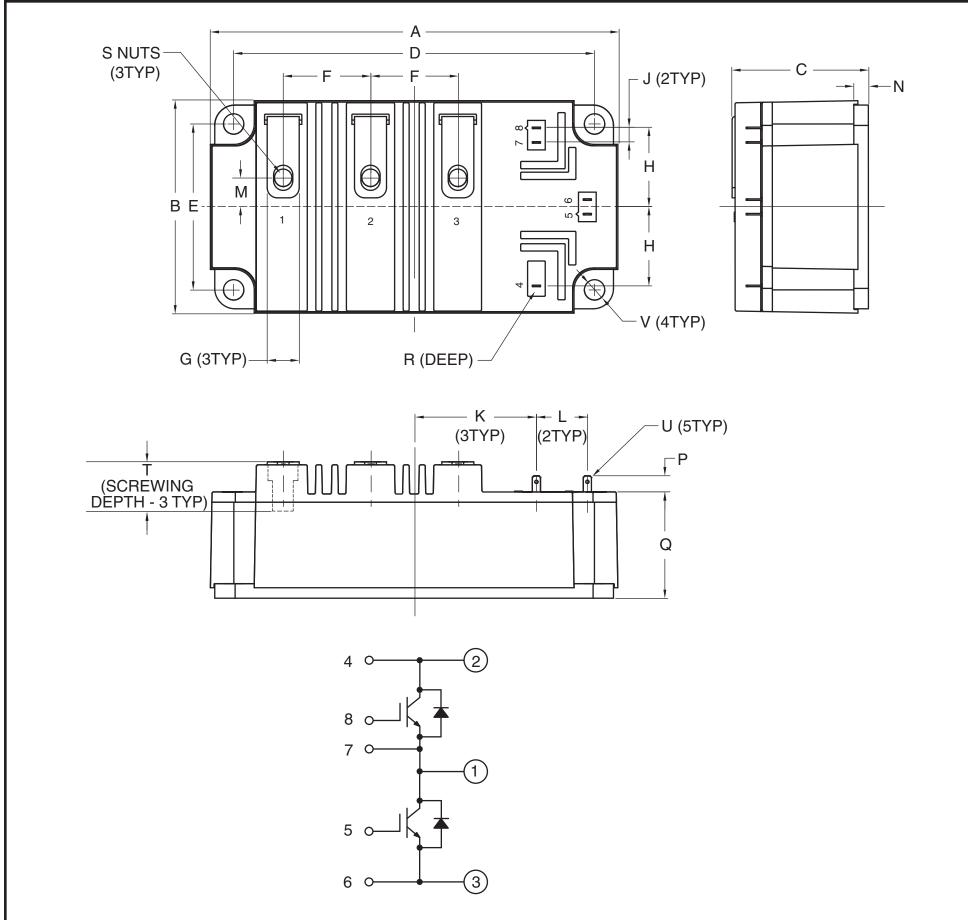
POWEREX

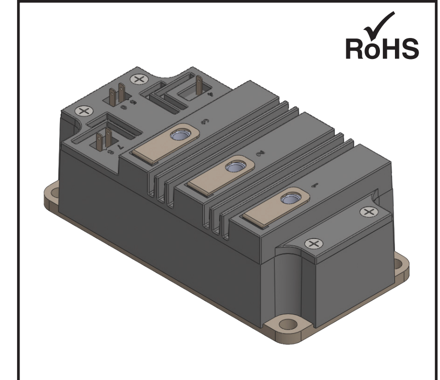
QID3320004

Powerex, Inc., 173 Pavilion Lane, Youngwood, Pennsylvania 15697 (724) 925-7272
www.pwrx.com

Dual IGBT HVIGBT Module

200 Amperes/3300 Volts





Outline Drawing and Circuit Diagram

Dimensions	Inches	Millimeters
A	5.51	140.0
B	2.87	73.0
C	1.50	38.0
D	4.88±0.01	124.0±0.25
E	2.24±0.01	57.0±0.25
F	1.18	30.0
G	0.43	11.0
H	1.07	27.15
J	0.20	5.0
K	1.65	42.0

Dimensions	Inches	Millimeters
L	0.69±0.01	17.5±0.25
M	0.38	9.75
N	0.20	5.0
P	0.22	5.5
Q	1.04	26.5
R	0.16	4.0
S	M5 Metric	M5
T	0.63 Min.	16.0 Min.
U	0.11 x 0.02	2.8 x 0.5
V	0.28 Dia.	7.0 Dia.

Description:

Powerex IGBT Modules are designed for use in switching applications. Each module consists of two IGBT Transistors in a half-bridge configuration with each transistor having a reverse-connected super-fast recovery free-wheel diode. All components and interconnects are isolated from the heat sinking baseplate, offering simplified system assembly and thermal management.

Features:

- ☐ Advanced Mitsubishi R-Series Chip Technology
- ☐ Low $V_{CE(sat)}$
- ☐ Creepage and Clearance meet IEC 60077-1
- ☐ High Isolation Voltage
- ☐ Rugged SWSOA and RRSOA
- ☐ Compact Industry Standard Package
- ☐ UL Recognized (E78240)

Applications:

- ☐ Medium Voltage Drives
- ☐ High Voltage Power Supplies

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Absolute Maximum Ratings, T_j = 25 °C unless otherwise specified

Ratings	Symbol	QID3320004	Units
Junction Temperature	T_j	-50 to +150	°C
Operating Temperature	T_{op}	-50 to +150	°C
Storage Temperature	T_{stg}	-55 to +150	°C
Collector-Emitter Voltage (V_{GE} = 0V)	V_{CES}	3300	Volts
Gate-Emitter Voltage (V_{CE} = 0V)	V_{GES}	±20	Volts
Collector Current (T_C = 102°C)	I_C	200	Amperes
Collector Current (T_C = 25°C)	I_C	370	Amperes
Peak Collector Current (Pulse)	I_{CM}	400*	Amperes
Diode Forward Current** (T_C = 99°C)	I_F	200	Amperes
Diode Forward Surge Current** (Pulse)	I_{FM}	400*	Amperes
I^2t for Diode (t = 10ms, V_R = 0V, T_j = 125°C)	I^2t	15	kA^2sec
Maximum Collector Dissipation (T_C = 25°C, IGBT Part, $T_{j(max)} \leq$ 150°C)	P_C	1780	Watts
Mounting Torque, M5 Terminal Screws	—	35	in-lb
Mounting Torque, M6 Mounting Screws	—	44	in-lb
Module Weight (Typical)	—	800	Grams
Isolation Voltage (Charged Part to Baseplate, AC 60Hz 1 min.)	V_{iso}	6.0	kVolts
Partial Discharge (V1 = 3500 V_{RMS}, V2 = 2600 V_{RMS}, f = 60Hz (Acc. to IEC 1287))	Q_{pd}	10	pC
Maximum Short-Circuit Pulse Width, ($V_{CC} \leq$ 2500V, $V_{CE} \leq V_{CES}$, V_{GE} = 15V, T_j = 125°C)	t_{psc}	10	µs

Electrical Characteristics, T_j = 25 °C unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Collector-Cutoff Current	I_{CES}	$V_{CE} = V_{CES}$, V_{GE} = 0V	—	—	2.0	mA
Gate Leakage Current	I_{GES}	$V_{GE} = V_{GES}$, V_{CE} = 0V	—	—	0.5	µA
Gate-Emitter Threshold Voltage	$V_{GE(th)}$	I_C = 15mA, V_{CE} = 10V	5.5	6.0	6.5	Volts
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	I_C = 200A, V_{GE} = 15V, T_j = 25°C	—	2.7***	3.0	Volts
		I_C = 200A, V_{GE} = 15V, T_j = 125°C	—	3.4	4.0	Volts
		I_C = 200A, V_{GE} = 15V, T_j = 150°C	—	3.6	—	Volts
Total Gate Charge	Q_G	V_{CC} = 1800V, I_C = 170A, V_{GE} = 15V	—	1.8	—	µC
Emitter-Collector Voltage**	V_{EC}	I_E = 200A, V_{GE} = 0V, T_j = 25°C	—	2.3	3.0	Volts
		I_E = 200A, V_{GE} = 0V, T_j = 125°C	—	2.45	—	Volts
		I_E = 200A, V_{GE} = 0V, T_j = 150°C	—	2.55	—	Volts

* Pulse width and repetition rate should be such that device junction temperature (T_j) does not exceed $T_{j(max)}$ rating.
**Represents characteristics of the anti-parallel, emitter-to-collector free-wheel diode (FWDi).
*** Pulse width and repetition rate should be such that device junction temperature rise is negligible.

Electrical Characteristics, T_j = 25 °C unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Input Capacitance	C_{ies}		—	23	—	nF
Output Capacitance	C_{oes}	V_{GE} = 0V, V_{CE} = 10V	—	1.5	—	nF
Reverse Transfer Capacitance	C_{res}		—	0.7	—	nF
Turn-on Delay Time	$t_{d(on)}$	V_{CC} = 1800V, I_C = 200A,	—	TBD	—	μs
Rise Time	t_r	V_{GE} = ±15V,	—	TBD	—	μs
Turn-off Delay Time	$t_{d(off)}$	$R_{G(on)}$ = 10Ω, $R_{G(off)}$ = 35Ω,	—	TBD	—	μs
Fall Time	t_f	L_S = 100nH, Inductive Load	—	TBD	—	μs
Turn-on Switching Energy	E_{on}	T_j = 150°C, I_C = 200A, V_{GE} = ±15V,	—	495	—	mJ/P
Turn-off Switching Energy	E_{off}	$R_{G(on)}$ = 10Ω, $R_{G(off)}$ = 35Ω,	—	360	—	mJ/P
		V_{CC} = 1800V, L_S = 100nH, Inductive Load				
Diode Reverse Recovery Time**	t_{rr}	V_{CC} = 1800V, I_E = 200A,	—	0.85	—	μs
Diode Reverse Recovery Charge**	Q_{rr}	V_{GE} = ±15V, $R_{G(on)}$ = 10Ω,	—	250*	—	μC
Diode Reverse Recovery Energy	E_{rec}	L_S = 100nH, Inductive Load, T_j = 150°C	—	265	—	mJ/P
Stray Inductance (C1-E2)	L_{SCE}		—	60	—	nH
Lead Resistance Terminal-Chip	R_{CE}		—	0.8	—	mΩ

Thermal and Mechanical Characteristics, T_j = 25 °C unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal Resistance, Junction to Case***	$R_{th(j-c)}$ Q	Per IGBT	—	0.060	—	°C/W
Thermal Resistance, Junction to Case***	$R_{th(j-c)}$ D	Per FWDi	—	0.096	—	°C/W
Contact Thermal Resistance, Case to Fin	$R_{th(c-f)}$	Per Module,	—	0.018	—	°C/W
		Thermal Grease Applied, λ_{grease} = 1W/mK				
Comparative Tracking Index	CTI		600	—	—	
Clearance Distance in Air (Terminal to Base)	$d_{a(t-b)}$		35.0	—	—	mm
Creepage Distance Along Surface (Terminal to Base)	$d_{s(t-b)}$		64	—	—	mm
Clearance Distance in Air (Terminal to Terminal)	$d_{a(t-t)}$		19	—	—	mm
Creepage Distance Along Surface (Terminal to Terminal)	$d_{s(t-t)}$		54	—	—	mm

*Pulse width and repetition rate should be such that device junction temperature rise is negligible.
**Represents characteristics of the anti-parallel, emitter-to-collector free-wheel diode (FWDi).
***T_C measurement point is just under the chips.

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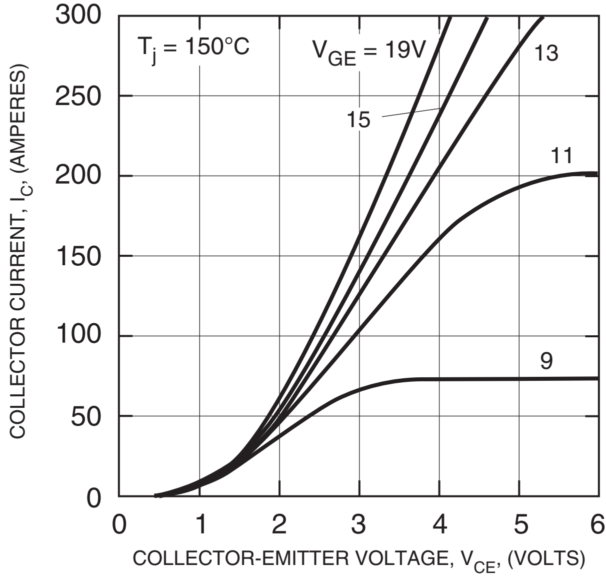

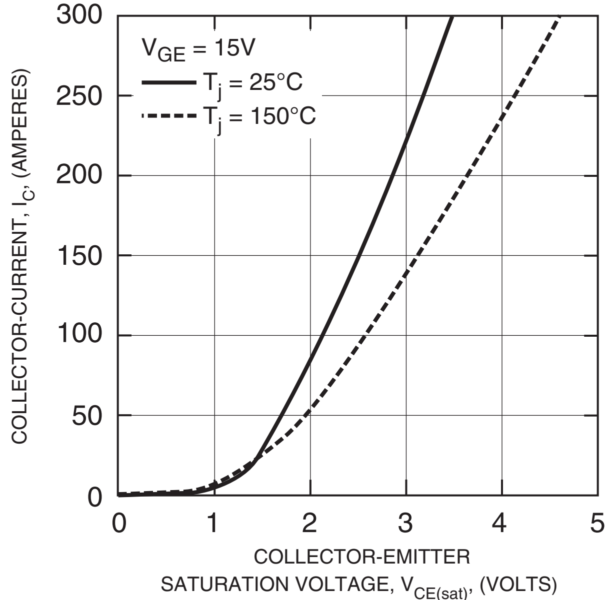

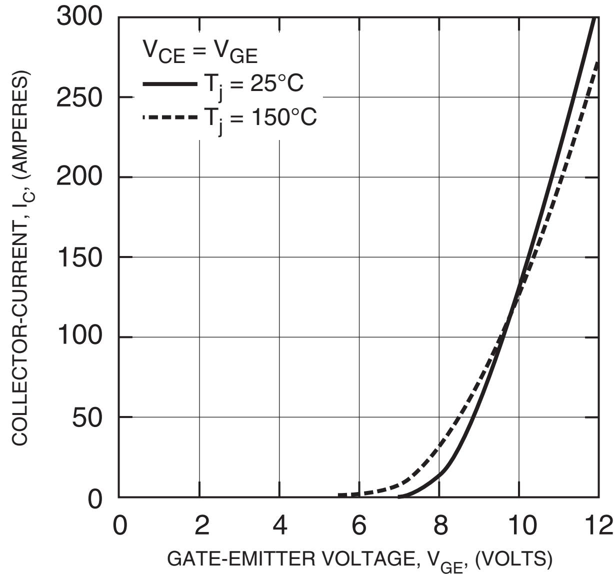

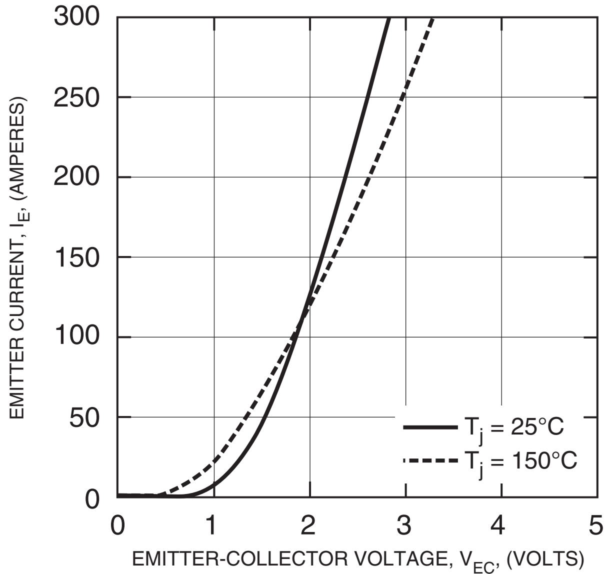

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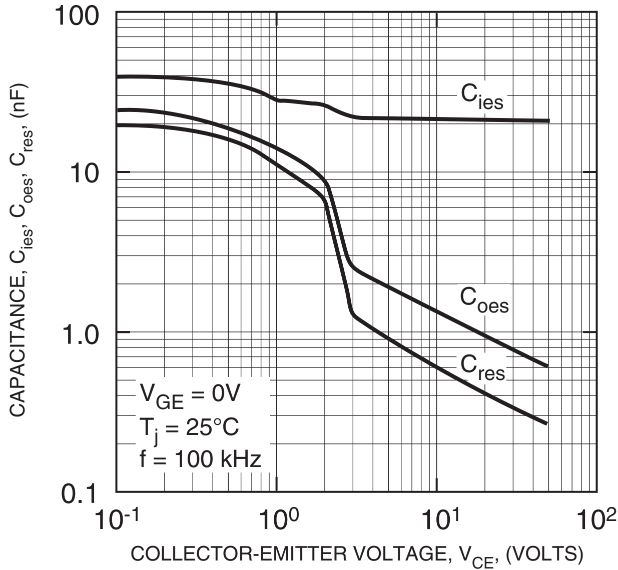

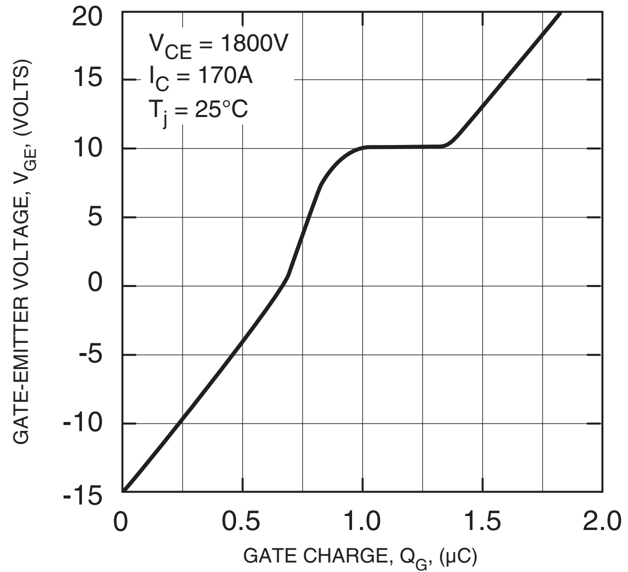

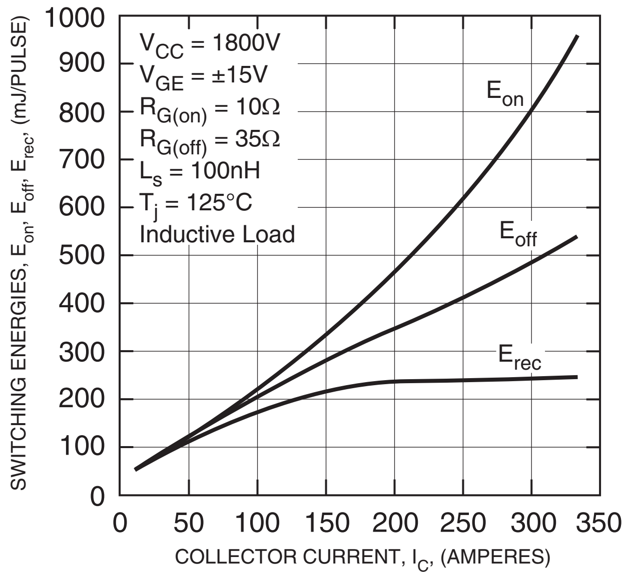

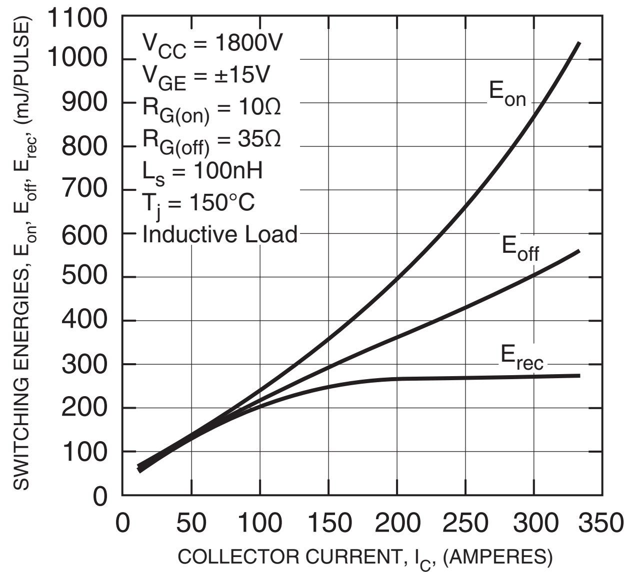

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